Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/808,763	LEE, KEVIN J.
Examiner	Art Unit
Lois Zheng	1742

SEARCHED					
Class	Subclass	Date	Examiner		
204	224M	1/5/2007	LLZ		
204	224R	1/5/2007	LLZ		
204	228.1	1/5/2007	LLZ		
204	229.1	1/5/2007	LLZ		
204	229.4	1/5/2007	LLZ		
204	229.8	1/5/2007	LLZ		
204	230.1	1/5/2007	LLZ		
204	230.2	1/5/2007	. LLZ		
205	641-644	1/5/2007	LLZ		
205	666-667	1/5/2007	LLZ		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventorship search	1/5/2007	LLZ		
EAST search	1/5/2007	LLZ		
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